

Clamp-type test probes



Product description

Clamp-type test probes provide the simple, rapid measurement of voltages.

A variety of types and sizes permit the measuring point to be accessed and gripped without difficulty.

The ergonomic design has been optimised to facilitate handling to the utmost extent.

The KLEPS 2700 permits a lead to be tested without the insulation being stripped.

The KLEPS 2800 is provided with claw-type clamps with which large

test specimens can be gripped. It is also suitable for testing currents. The classic KLEPS 30, used in millions of applications worldwide, serves as a versatile voltage tap.

*System Article type		Technical Data	Order no. Colour	*System Article type		Technical Data	Order no. Colour
KLEPS 2	3.8 9.2 9.5 9.5 9.5 9.5 9.5 9.5 9.5 9.5	Clamping range max. ø 2 mm, contact hook, solder contact	931 467-100 • 931 467-101 •	(64) MICRO-KLEPS	01.4	Very thin wires and densely packed contact points, clamping range ø 2 mm	973 972-100 ● 973 972-101 ●
② KLEPS 2-BU	3.8 9.2 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0	Clamping range max. ø 2 mm, contact hook	973 501-100 ● 973 501-101 ●	(64) KLEPS 3 ST	923 2 2 3 3 8 7	Very thin wires and densely packed contact points, clamping range ø 3.5 mm	973 592-100 ● 973 592-101 ●
(4) KLEPS 10	94.5 3.4 3.4 88.3 88.3	20 A clamping range max. ø 2 mm	930 111-100 • 930 111-101 •	(64)	923 2 7 8 93	Very thin wires and densely packed contact points, clamping range ø 3.5 mm	973 649-100 • 973 649-101 •
€ KLEPS 2900	4.3 4.3 4.3 4.3 4.3 4.3 4.3 4.3	20 A clamping range 5.5 mm	972 309-100 ● 972 309-101 ●	(4) KLEPS 30	3.5	Clamping range ø 4 mm	930 113-100 • 930 113-101 •



